## Abstract Submitted for the MAR10 Meeting of The American Physical Society

Proximity Effect  $\mathbf{in}$ **Electron-Doped** Cuprate Josephson junctions<sup>1</sup> S. CHARPENTIER, Département de Physique, Université de Sherbrooke, Sherbrooke, Canada, G. ROBERGE, S. GODIN-PROULX, P. FOURNIER — We study the proximity effect in Josephson junctions made from electron-doped high-T<sub>c</sub> cuprates  $Pr_{2-x}Ce_xCuO_4$  (PCCO) as the electrodes and the barrier. For the electrodes, we use superconducting optimally doped PCCO (x =0.15). PCCO x = 0.05, an antiferromagnetic metal, is used for the barrier. Our results demonstrate: 1) a conventional proximity effect; 2) but a coupling even if the barrier is antiferromagnetic. We determine the normal coherence length,  $\xi_n$ , which quantifies the extent of the pair wavefunction into the metal. Comparing this value with the theoretical expectations, we confirm that the coupling appears to be conventional through PCCO x = 0.05. Further results investigating the coupling through an insulating antiferromagnetic barrier and through a metal with no antiferromagnetic order will also be presented.

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